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Specification for Approval

Customer:	
Model Name:	

Sı	upplier Approv	Customer approval	
R&D Designed	R&D Approved	QC Approved	
Peter	Peng Jun		



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Revision Record

REV NO.	REV DATE	CONTENTS	Note
А	2012-11-15	NEW ISSUE	

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1. Scope

This specification defines general provisions as well as inspection standards for TFT module supplied by AMSON electronics.

If the event of unforeseen problem or unspecified items may occur, naturally shall negotiate and agree to solution

2. General Information

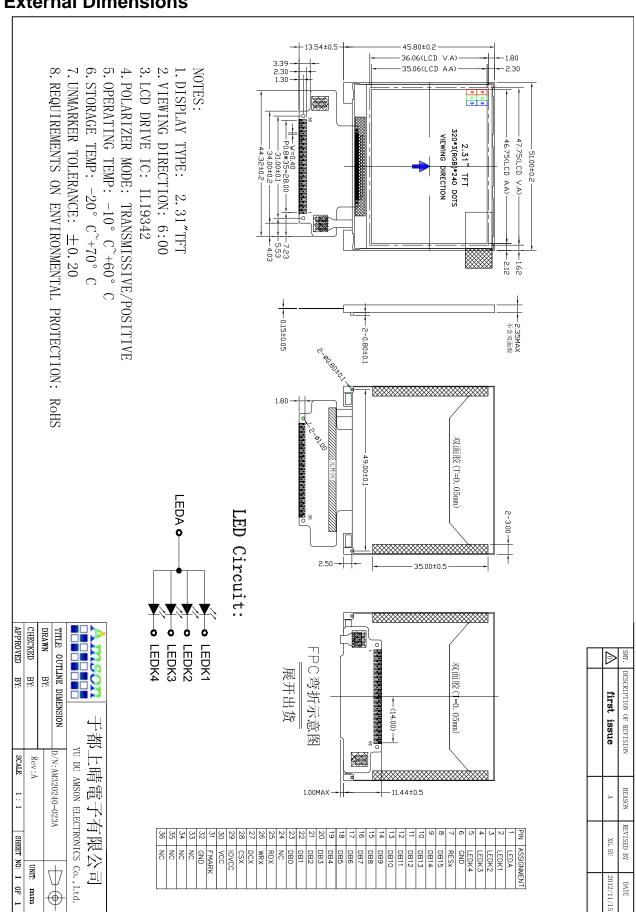
ITEM	STANDARD VALUES			
LCD type	2.31"TFT			
Dot arrangement	320(RGB)×240	dots		
Color filter array	RGB vertical stripe			
Display mode	TN / Transmission / Normally White			
Viewing Direction	6 o'clock(Gray scale inversion)			
Driver IC	IL19342C			
Module size	51.0(W)×45.8(H)×2.35(T)	mm		
Active area	46.752(W)×35.064(H)	mm		
Dot pitch	0.1461(W)×0.1461(H)	mm		
Interface	i80-system 8/16 bit MCU interface			
Operating temperature	-20 ~ +70	°C		
Storage temperature	-30 ~ +80	°C		
Back Light	4 White LED In Parallel			
Weight	TBD	g		



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3. External Dimensions





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4. Interface Description

4. Inter	face Desc	ription				
PIN NO.	PIN NAME	DESCRIPTION				
1	LEDA	Power supply for backlight anode input terminal.				
2	LEDK1	Power supply for backlight cathode input terminals.				
3	LEDK2	Power supply for backlight cathode input terminals.				
4	LEDK3	Power supply for backlight cathode input terminals.				
5	LEDK4	Power supply for backlight cathode input terminals.				
6	GND	System power ground				
7	RESX	Reset signal input terminal, active at 'L'.				
8	DB15					
9	DB14					
10	DB13					
11	DB12					
12	DB11					
13	DB10					
14	DB9	DATA DUO				
15	DB8	DATA BUS. 8-bit interface: DB [7:0] is used.				
16	DB7	16-bit interface: DB [7:0] is used.				
17	DB6					
18	DB5					
19	DB4					
20	DB3					
21	DB2					
22	DB1					
23	DB0					
24	NC	No Connection				
25	RDX	Read signal input terminal, Active at 'L'.				
26	WRX	Write signal input terminal, Active at 'L'.				
	501	Register select signal input terminal:				
27	DCX	DCX='H': select a control register; DCX='L': select an index or status register.				
28	CSX	Chip select signal input terminal, Active at 'L'.				
29	IOVCC	Logic Supply Voltage (1.8V/2.8V).				
30	VCC	Analog Supply Voltage (2.8V).				
31	FMARK	Tearing effect output pin to synchronize MPU to frame writing.				
32	GND	System power ground				
33	NC	Gystem power ground				
34	NC					
35	NC	No Connection				
36	NC					
	140					



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5. Absolute Maximum Ratings

Item	Symbol	Min.	Max.	Unit
Logic Supply Voltage	IOVCC	-0.3	3.3	V
Analog Supply Voltage	VCC	-0.3	3.6	V
Input Voltage	Vin	-0.3	IOVCC+0.3	V
Operating Temperature	Тор	-20	70	°C
Storage Temperature	Тѕт	-30	80	°C
Storage Humidity	HD	20	90	%RH

6. DC Characteristics

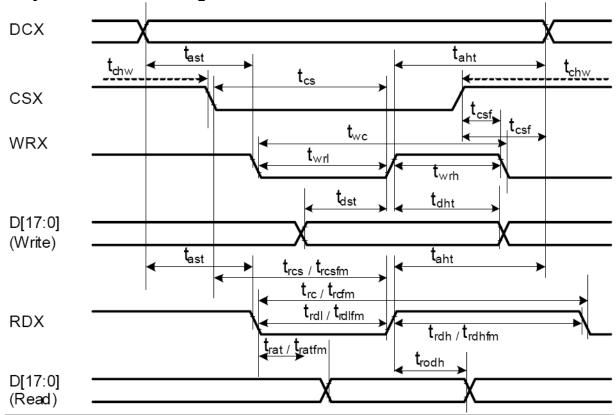
Item	Symbol	Min.	Тур.	Max.	Unit	Remark
Logic Supply Voltage	IOVCC	1.65	1.8/2.8	3.3	٧	
Analog Supply Voltage	VCC	2.6	2.8	3.3	٧	
Input High Voltage	V _{IH}	0.8IOVCC		IOVCC	٧	Digital input pins
Input Low Voltage	V _{IL}	GND		0.2IOVCC	٧	Digital input pins
Output High Voltage	V _{OH}	0.8IOVCC	-	IOVCC	٧	Digital output pins
Output Low Voltage	V _{OL}	GND	-	0.2IOVCC	V	Digital output pins
I/O Leak Current	ILI	-1		1	uA	

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7. Timing Characteristics

7.1 i80-System Interface Timing Characteristics

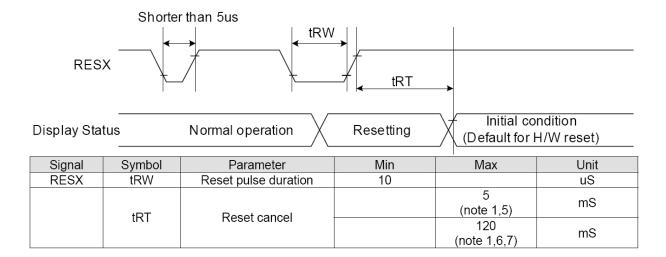


Signal	Symbol	Parameter	min	max	Unit	Description
DCX	t _{ast}	t _{ast} Address setup time		-	ns	
DCX	t _{hat}	Address hold time (Write/Read)	10	-	ns	
	t _{chw}	CSX "H" pulse width	0	-	ns	
	t _{cs}	Chip Select setup time (Write)	15	-	ns	
CSX	t _{rcs}	Chip Select setup time (Read ID)	45	-	ns	
	t _{rcsfm}	Chip Select setup time (Read FM)	355	-	ns	
	t _{csf}	Chip Select Wait time (Write/Read)	10	-	ns	
	t _{wc}	Write cycle	66		ns	
WRX	t _{wrh}	Write Control pulse H duration	33	-	ns	
	t _{wrl}	Write Control pulse L duration	33	-	ns	
	t _{rc}	Read cycle (ID)	160	-	ns	
RDX (ID)	t _{rdh}	Read Control pulse H duration	90	-	ns	When read ID data
	t _{rdl}	Read Control pulse L duration	45	-	ns	
	t _{rcfm}	Read Cycle (FM)	450	-	ns	When read from the frame
RDX (FM)	t _{rdhfm}	Read Control H duration (FM)	90	-	ns	
	t _{rdlfm}	Read Control L duration (FM)	355	-	ns	memory
DD[47.0]	t _{dst}	Write data setup time	10	-	ns	
DB[17:0],	t _{dht}	Write data hold time	10	-	ns	For maximum CL =20nF
DB[15:0], DB[8:0],	t _{rat}	Read access time	-	40	ns	For maximum CL=30pF For minimum CL=8pF
DB[8:0], DB[7:0]	t _{ratfm}	Read access time	-	50	ns	1 Of Hillimidill CL-8pr
00[7.0]	t _{rod}	Read output disable time	45	50	ns	

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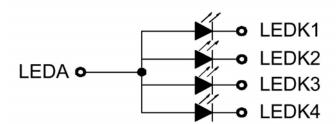
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7.2 Reset Timing Characteristics



8. Backlight Characteristics

LED Circuit:



Item	Symbol	MIN	TYP	MAX	UNIT	Test Condition
Supply Voltage	Vf	3.0	3.2	3.5	V	If=60mA
Supply Current	If		60	80	mA	
Luminous Intensity for LCM		200	230		Cd/m ²	If=60mA
Uniformity for LCM		80			%	If=60mA
Life Time		20000			Hr	If=60mA
Backlight Color		\	If=60mA			

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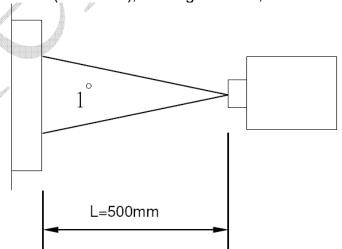
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9. Optical Characteristics

Item		Symbol	Condition	Min.	Тур.	Max.	Unit	Remark
Transmitta	ance	T		6.0	6.3		%	
Contrast F	Ratio	CR		400	500			Note3
Response	Time	Tr+Tf	25°C		20	30	ms	Note4
	3H	θ3H(R)		60	70			
Viewing	9H	θ9H(L)	CD>10	60	70			Note5
Angle	6H	φ6H(D)	CR≥10	50	60			Notes
	12H	φ12(U)		60	70			
		Х	θ=φ=0°	0.255	0.305	0.355		
	White	у		0.311	0.361	0.411		
		λ						
		Х	θ=φ=0°	0.571	0.621	0.671		
	Red	у		0.269	0.319	0.369	-	
Colon Filton		λ						
Color Filter Chromaticity		Х		0.252	0.302	0.352		Note6
Cilioniaticity	Green	у	θ=φ=0°	0.515	0.565	0.615		
		λ						
		Х		0.087	0.137	0.187		
	Blue	у	θ=φ=0°	0.114	0.164	0.214		
		λ						
	NTSC			45 %	50 %			

Note1.Ambient condition: 25°C±2°C, 60±10%RH, under 10 Lux in the darkroom.

Note2.Measure device: BM-5A (TOPCON), viewing cone=1°, IL=20mA.

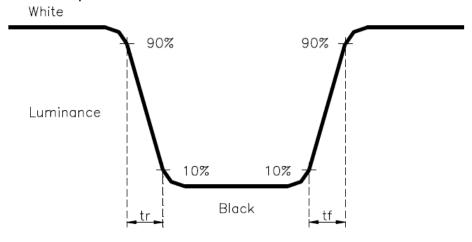


Note3. Definition of Contrast Ratio:

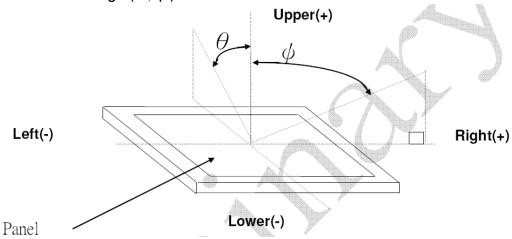
CR = White Luminance (ON) / Black Luminance (OFF)

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Note4. Definition of response time: The response time is defined as the time interval between the 10% and 90% amplitudes.



Note5. Definition of view angle(θ , ϕ):



Note6. Light source: C light.



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10. Reliability Test Conditions and Methods

NO.	TEST ITEMS	TEST CONDITION	INSPECTION AFTER TEST
	High Temperature Storage	80°C±2°C×200Hours	
	Low Temperature Storage	-30°C±2°C×200Hours	
	High Temperature Operating	70°C±2°C×120Hours	Inspection after 2~4hours
	Low Temperature Operating	-20°C±2°C×120Hours	storage at room temperature, the samples should be free from
	Temperature Cycle(Storage)	-20°C \Longrightarrow 25°C \Longrightarrow 70°C (30min) (30min) 1cycle Total 10cycle	defects: 1, Air bubble in the LCD. 2, Seal leak. 3, Non-display. 4, Missing segments.
	Damp Proof Test (Storage)	50°C±5°C×90%RH×120Hours	5, Glass crack. 6, Current IDD is twice higher than initial value.
	Vibration Test	Frequency:10Hz~55Hz~10Hz Amplitude:1.5M X,Y,Z direction for total 3hours (Packing Condition)	7, The surface shall be free from damage. 8, The electric characteristic requirements shall be
	Drooping Test	Drop to the ground from 1M height one time every side of carton. (Packing Condition)	satisfied.
	ESD Test	Voltage:±8KV,R:330Ω,C:150PF,Air Mode,10times	

REMARK:

- 1, The Test samples should be applied to only one test item.
- 2, Sample side for each test item is 5~10pcs.
- 3,For Damp Proof Test, Pure water(Resistance $> 10M\Omega$)should be used.
- 4,In case of malfunction defect caused by ESD damage, if it would be recovered to normal state after resetting, it would be judge as a good part.
- 5, EL evaluation should be accepted from reliability test with humidity and temperature: Some defects such as black spot/blemish can happen by natural chemical reaction with humidity and Fluorescence EL has.
- 6, Failure Judgment Criterion: Basic Specification Electrical Characteristic, Mechanical Characteristic, Optical Characteristic.



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11. Inspection Standard

This standard apply to C-STN/TFT module

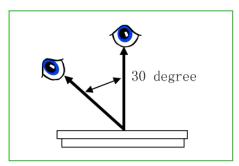
1. Spot check plan:

According to spot check level ${\rm II}$,MIL-STD-105D Level ${\rm II}$,the rank of accept or reject is below:

3A、2A: major non-conformance: AQL 0.25 minor non-conformance: AQL 0.4

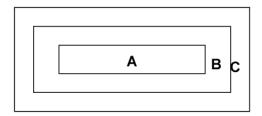
1A: major non-conformance: AQL 0.65 minor non-conformance: AQL 1.

2. Inspection condition:



Under daylight lamp 20 \sim 40W, product distance inspector 'eye 30cm,incline degree 30° $_{\circ}$

3. LCD area define:



Area A: display area

Area B: VA area

Area C: out of VA area, not in sight after assembly

Remark: non-conformance at area C, but is OK that isn't influence reliability of product & assembly by customer.



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4. Inspection standard

4.1 Major non-conformance

NO.	Item	Inspection standard	Rate	
4.1.1	Function non-conformance	 No display, display abnormally Miss line, short B/L no function or function abnormally TP no function 	major	
4.1.2	miss	No matter miss what component		
4.1.3	Out of size	Module dimension out of spec		

4.2 Appearance non-conformance

NO.	Item	Inspection standard							Rate
4.2.1	Black or white spot (power on)	dot non-conformance define Φ $\Phi = \frac{+y}{2} x ($							
		A grade							
		area size (mm)			Mos	t approv			
				Α		В	С		
		Ф≤0.10		ignore				Minor	
		0.10<Φ≤0.15		4					
		0.15<Φ≤0.20		2			ignor	e	
		0.20<Φ≤0.25		1					
		0.25<Ф		0					
		Most approve 4 damages, dot to dot ≥10mm							
	Black or white line (power on)	A grade							
		Size(mm)			Most approve			q'ty	
		L(length)	W(w	ridth)	,	A	В	С	
		ignore	W≤0.03		ignore				
4.2.2		L≤5.0	0.03< W≤0.05		3				Minor
		L≤3.0	0.05< W≤0.07		2		ignore		
			0.07 <w< td=""><td colspan="2">Treat with dot non-conformance</td><td></td></w<>		Treat with dot non-conformance				
		Most approve 3 damages, line to line ≥10mm							



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4.2.3	Polarizer position	'		et drawing, dis over display a			Minor
4.2.4	LCD non-conform ance	(iii) commo	z ∫ X ≤3.0	Y <frame edge<="" th=""/> <th>Z ignore</th> <th></th> <th>Minor</th>	Z ignore		Minor
4.2.5	Contrast voltage warp	VOP/VIcd voltage of confirmed sample \pm 0.15V					
4.2.6	color	Color & luminance of module scope reference spec					Minor
4.2.7	Cross talk	Reference confirmed limit sample					Minor



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12. Handling Precautions

12.1 Mounting method

The LCD panel of AMSON TFT module consists of two thin glass plates with polarizes which easily be damaged. And since the module in so constructed as to be fixed by utilizing fitting holes in the printed circuit board.

Extreme care should be needed when handling the LCD modules.

12.2 Caution of LCD handling and cleaning

When cleaning the display surface, Use soft cloth with solvent

[Recommended below] and wipe lightly

- Isopropyl alcohol
- Ethyl alcohol

Do not wipe the display surface with dry or hard materials that will damage the polarizer surface.

Do not use the following solvent:

- Water
- Aromatics

Do not wipe ITO pad area with the dry or hard materials that will damage the ITO patterns Do not use the following solvent on the pad or prevent it from being contaminated:

- Soldering flux
- Chlorine (CI), Sulfur (S)

If goods were sent without being sili8con coated on the pad, ITO patterns could be damaged due to the corrosion as time goes on.

If ITO corrosion happen by miss-handling or using some materials such as Chlorine (CI), Sulfur (S) from customer, Responsibility is on customer.

12.3 Caution against static charge

The LCD module use C-MOS LSI drivers, so we recommended that you:

Connect any unused input terminal to VCC or GND, do not input any signals before power is turned on, and ground your body, work/assembly areas, and assembly equipment to protect against static electricity.

12.4 packing

- Module employs LCD elements and must be treated as such.
- Avoid intense shock and falls from a height.
- To prevent modules from degradation, do not operate or store them exposed direct to sunshine or high temperature/humidity

12.5 Caution for operation

- It is an indispensable condition to drive LCD's within the specified voltage limit since the higher voltage then the limit cause the shorter LCD life.
- An electrochemical reaction due to direct current causes LCD's undesirable deterioration, so that the use of direct current drive should be avoided.
- Response time will be extremely delayed at lower temperature then the operating temperature range and on the other hand at higher temperature LCD's how dark color in them. However those phenomena do not mean malfunction or out of order with LCD's, which will come back in the specified operation temperature.
- If the display area is pushed hard during operation, some font will be abnormally displayed but it resumes normal condition after turning off once.
- Slight dew depositing on terminals is a cause for electro-chemical reaction resulting in terminal open circuit.



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Usage under the maximum operating temperature, 50%Rh or less is required.

12.6 storing

In the case of storing for a long period of time for instance, for years for the purpose or replacement use, the following ways are recommended.

- Storage in a polyethylene bag with the opening sealed so as not to enter fresh air outside in it. And with no desiccant.
- Placing in a dark place where neither exposure to direct sunlight nor light's keeping the storage temperature range.
- Storing with no touch on polarizer surface by the anything else.
 [It is recommended to store them as they have been contained in the inner container at the time of delivery from us

12.7 Safety

- It is recommendable to crash damaged or unnecessary LCD's into pieces and wash off liquid crystal by either of solvents such as acetone and ethanol, which should be burned up later.
- When any liquid leaked out of a damaged glass cell comes in contact with your hands, please wash it off well with soap and water

13. Precaution for Use

13.1

A limit sample should be provided by the both parties on an occasion when the both parties agreed its necessity. Judgment by a limit sample shall take effect after the limit sample has been established and confirmed by the both parties.

13.2

On the following occasions, the handing of problem should be decided through discussion and agreement between responsible of the both parties.

- When a question is arisen in this specification
- When a new problem is arisen which is not specified in this specifications
- When an inspection specifications change or operating condition change in customer is reported to AMSON TFT, and some problem is arisen in this specification due to the change
- When a new problem is arisen at the customer's operating set for sample evaluation in the customer site.

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14. Packing Method

